

# Product data sheet

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## AO4882-MS HF Compiance

#### Application

Battery protection

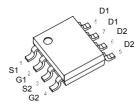
Load switch

Uninterruptible power supply

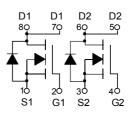
#### **General Features**

 $V_{DS} = 40V I_{D} = 6A$ 

 $R_{DS(ON)} < 30m\Omega @ V_{GS} = 10V$ 







N-Channel MOSFET

#### Absolute Maximum Ratings (T\_A=25 $^\circ\!\mathrm{C}$ unless otherwise noted)

Symbol	Parameter	Rating	Units
Vds	Drain-Source Voltage	40	V
Vgs	V <sub>GS</sub> Gate-Source Voltage		V
I <sub>D</sub> @T <sub>A</sub> =25°C	Continuous Drain Current <sup>1</sup>	6	A
ID@TA=70°C	Continuous Drain Current <sup>1</sup>	4	A
Ідм	Pulsed Drain Current <sup>2</sup>	36	A
EAS	Single Pulse Avalanche Energy <sup>3</sup>	31	mJ
las	Avalanche Current	25	A
PD@TA=25°C	Total Power Dissipation <sup>4</sup>	1.9	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Reja	Thermal Resistance Junction-ambient¹(t≤10s)	40	°C/W
	Thermal Resistance Junction-ambient <sup>1</sup>	65	°C/W



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	40			V
∕_BVbss/∠/Tj	BVDSS Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =1mA		0.032		V/°C
		V <sub>GS</sub> =10V , I <sub>D</sub> =6A		25	30	
RDS(ON)	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =4.5V , I <sub>D</sub> =4A		35	45	mΩ
VGS(th)	Gate Threshold Voltage		1.2	1.6	2.5	V
extstyle VGS(th)	V <sub>GS(th)</sub> Temperature Coefficient	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA		-4.8		mV/°C
_		V <sub>DS</sub> =32V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1	
loss	Drain-Source Leakage Current	V <sub>DS</sub> =32V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			5	uA
lgss	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =6A		32		S
Rg	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		2.1		
Qg	Total Gate Charge (4.5V)			9.8		
Qgs	Gate-Source Charge			2.8		nC
Qgd	Gate-Drain Charge	_		3.9		
Td(on)	Turn-On Delay Time			2.8		
Tr	Rise Time			40.4		
Td(off)	Turn-Off Delay Time	I₀=6A		22.8		ns
T <sub>f</sub>	Fall Time	_		6.4		
Ciss	Input Capacitance			1013		
Coss	Output Capacitance			107		pF
Crss	Reverse Transfer Capacitance			76		
ls	Continuous Source Current <sup>1,5</sup>				8	A
lsм	Pulsed Source Current <sup>2,5</sup>	$-V_G=V_D=0V$ , Force Current			36	A
Vsd	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C			1	V
trr	Reverse Recovery Time	I⊧=7A , dl/dt=100A/µs ,		10		nS
Qrr	Reverse Recovery Charge	TJ=25°C		3.3		nC

#### Electrical Characteristics (TJ=25 °C, unless otherwise noted)

Note :

1. The data tested by surface mounted on a 1 inch $^2$  FR-4 board with 2OZ copper.

2. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%

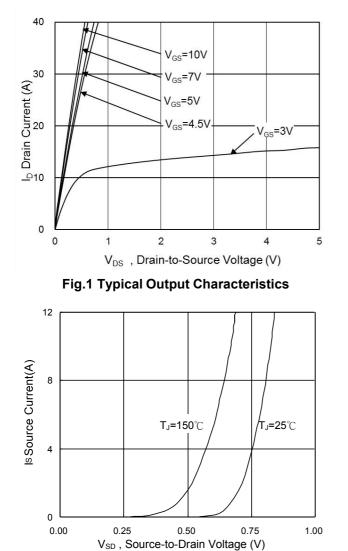
3. The EAS data shows Max. rating . The test condition is  $V_{DD}$ =25V,  $V_{GS}$ =10V, L=0.1mH, I<sub>AS</sub>=25A

4.The power dissipation is limited by 150  $^\circ\text{C}$  junction temperature

5. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.







**Typical Characteristics** 

Fig.3 Forward Characteristics of Reverse

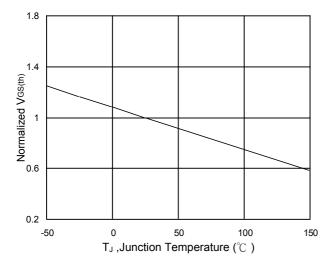


Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$ 

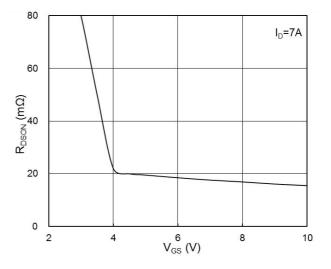


Fig.2 On-Resistance vs. G-S Voltage

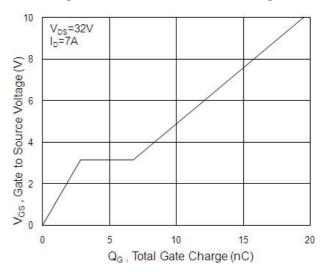


Fig.4 Gate-Charge Characteristics

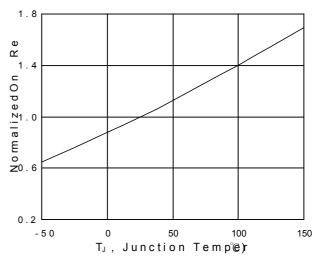


Fig.6 Normalized RDSON vs. TJ





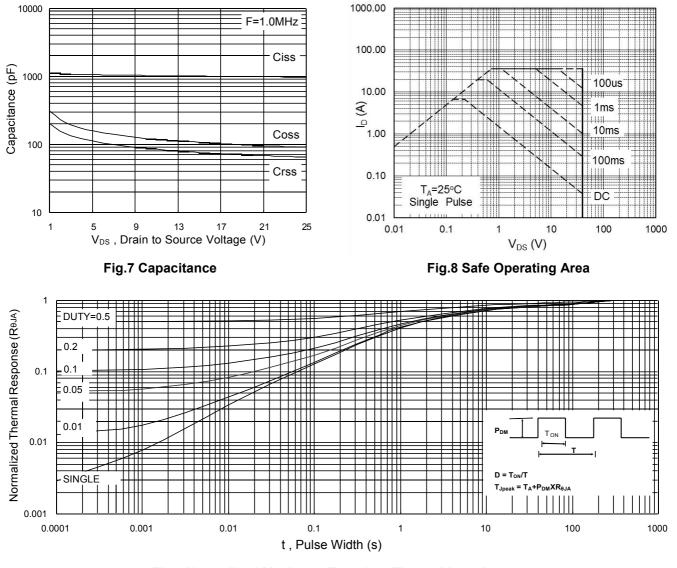


Fig.9 Normalized Maximum Transient Thermal Impedance

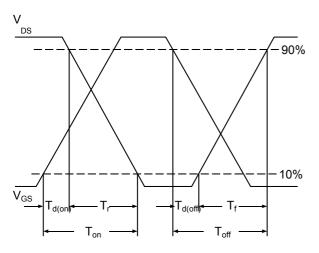
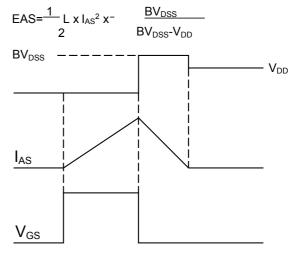
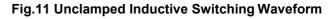


Fig.10 Switching Time Waveform

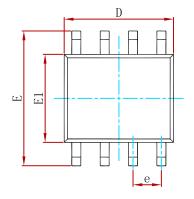


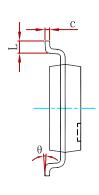


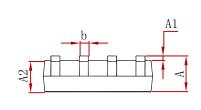


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#### PACKAGE MECHANICAL DATA

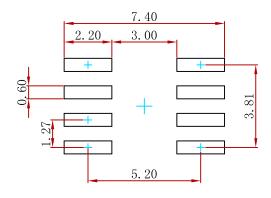






Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
А	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
с	0.170	0.250	0.007	0.010	
D	4.800	5.000	0.189	0.197	
e	1.270 (BSC)		0.050 (BSC)		
Е	5.800	6.200	0.228	0.244	
E1	3.800	4.000	0.150	0.157	
L	0.400	1.270	0.016	0.050	
θ	0 °	8°	0 °	8°	

### Suggested Pad Layout



#### Note:

1.Controlling dimension:in millimeters.

2.General tolerance:± 0.05mm.

3. The pad layout is for reference purposes only.

#### **REEL SPECIFICATION**

P/N	PKG	QTY
AO4882-MS	SOP-8	3000





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